

**HEXFET® POWER MOSFET
THRU-HOLE (Low-ohmic TO-254AA)**

**IRF7MS2907
75V, N-CHANNEL**

Product Summary

Part Number	BVDSS	R _{Ds(on)}	I _D
IRF7MS2907	75V	0.0055Ω	45A*

Seventh Generation HEXFET® power MOSFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon unit area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

These devices are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high-energy pulse circuits.



Features:

- Low R_{Ds(on)}
- Avalanche Energy Ratings
- Dynamic dv/dt Rating
- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Light Weight

Absolute Maximum Ratings

	Parameter		Units
I _D @ V _{GS} = 10V, T _C = 25°C	Continuous Drain Current	45*	A
I _D @ V _{GS} = 10V, T _C = 100°C	Continuous Drain Current	45*	
I _{DM}	Pulsed Drain Current ①	180	
P _D @ T _C = 25°C	Max. Power Dissipation	208	W
	Linear Derating Factor	1.67	W/C
V _{GS}	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	760	mJ
I _{AR}	Avalanche Current ①	45	A
E _{AR}	Repetitive Avalanche Energy ①	20.8	mJ
dv/dt	Peak Diode Recovery dv/dt ③	2.2	V/ns
T _J	Operating Junction	-55 to 150	°C
T _{TSG}	Storage Temperature Range		
	Lead Temperature	300 (0.063in./1.6mm from case for 10s)	
	Weight	4.3 (Typical)	g

* Current is limited by package

For footnotes refer to the last page

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (Unless Otherwise Specified)

	Parameter	Min	Typ	Max	Units	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	75	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Temperature Coefficient of Breakdown Voltage	—	0.087	—	V°C	Reference to 25°C , $\text{I}_D = 1.0\text{mA}$
$\text{R}_{\text{DS(on)}}$	Static Drain-to-Source On-State Resistance	—	—	0.0055	Ω	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 45\text{A}$ ④
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	2.0	—	4.0	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$
g_{fs}	Forward Transconductance	70	—	—	S (Ω)	$\text{V}_{\text{DS}} > 15\text{V}, \text{I}_{\text{DS}} = 45\text{A}$ ④
I_{DSS}	Zero Gate Voltage Drain Current	—	—	20	μA	$\text{V}_{\text{DS}} = 75\text{V}, \text{V}_{\text{GS}} = 0\text{V}$
		—	—	250		$\text{V}_{\text{DS}} = 60\text{V}, \text{V}_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Leakage Forward	—	—	100	nA	$\text{V}_{\text{GS}} = 20\text{V}$
I_{GSS}	Gate-to-Source Leakage Reverse	—	—	-100		$\text{V}_{\text{GS}} = -20\text{V}$
Q_g	Total Gate Charge	—	—	375	nC	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 45\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	60		$\text{V}_{\text{DS}} = 60\text{V}$
Q_{gd}	Gate-to-Drain ('Miller') Charge	—	—	150		
$t_{\text{d(on)}}$	Turn-On Delay Time	—	—	40	ns	$\text{V}_{\text{DD}} = 38\text{V}, \text{I}_D = 45\text{A}$ $\text{V}_{\text{GS}} = 10\text{V}, \text{R}_G = 1.2\Omega$
t_r	Rise Time	—	—	135		
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	—	175		
t_f	Fall Time	—	—	75		
$L_S + L_D$	Total Inductance	—	6.8	—	nH	Measured from Drain lead (6mm /0.25in. from package) to Source lead (6mm /0.25in. from package) with Source wires internally bonded from Source Pin to Drain Pad
C_{iss}	Input Capacitance	—	12060	—	pF	$\text{V}_{\text{GS}} = 0\text{V}, \text{V}_{\text{DS}} = 25\text{V}$ $f = 1.0\text{MHz}$
C_{oss}	Output Capacitance	—	2280	—		
C_{rss}	Reverse Transfer Capacitance	—	605	—		

Source-Drain Diode Ratings and Characteristics

	Parameter	Min	Typ	Max	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	45*	A	
I_{SM}	Pulse Source Current (Body Diode) ①	—	—	180		
V_{SD}	Diode Forward Voltage	—	—	1.0	V	$T_J = 25^\circ\text{C}, I_S = 45\text{A}, \text{V}_{\text{GS}} = 0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	—	175	ns	$T_J = 25^\circ\text{C}, I_F = 45\text{A}, dI/dt \leq 100\text{A}/\mu\text{s}$ $\text{V}_{\text{DD}} \leq 25\text{V}$ ④
Q_{RR}	Reverse Recovery Charge	—	—	850	nC	
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_S + L_D$.				

* Current is limited by package

Thermal Resistance

	Parameter	Min	Typ	Max	Units	Test Conditions
R_{thJC}	Junction-to-Case	—	—	0.6	$^\circ\text{C}/\text{W}$	

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

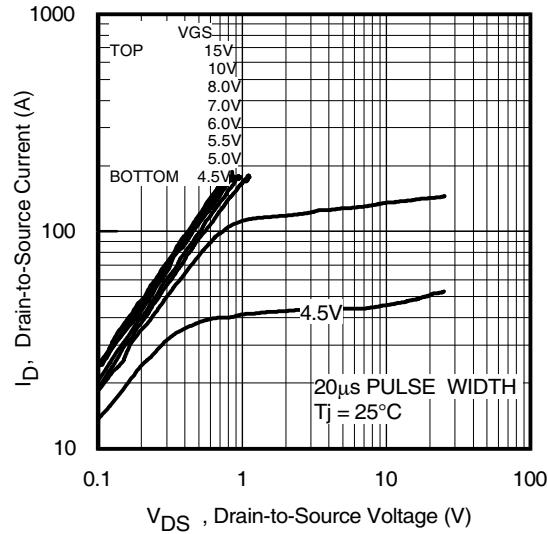


Fig 1. Typical Output Characteristics

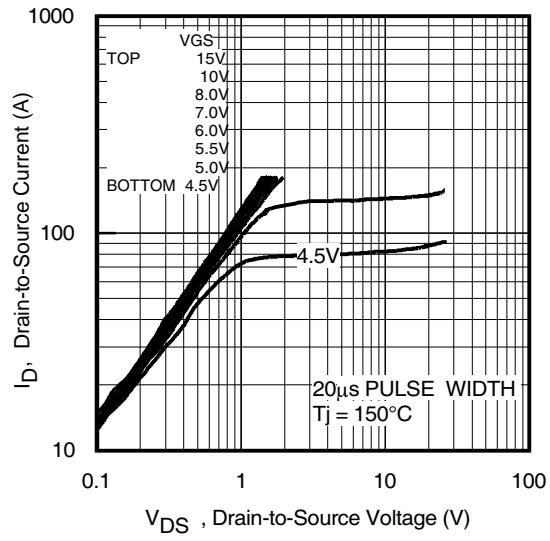


Fig 2. Typical Output Characteristics

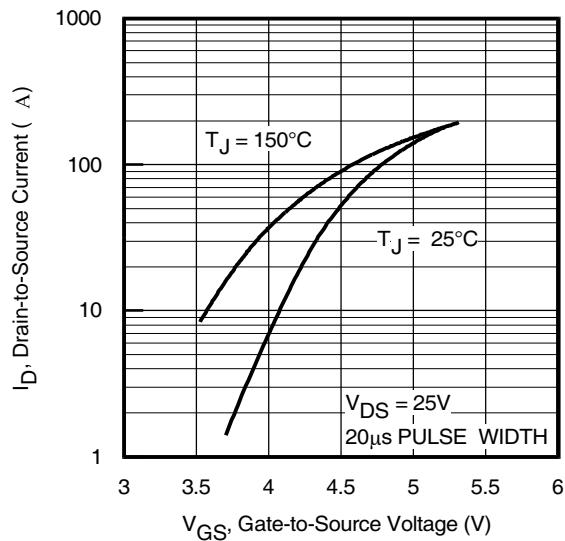


Fig 3. Typical Transfer Characteristics

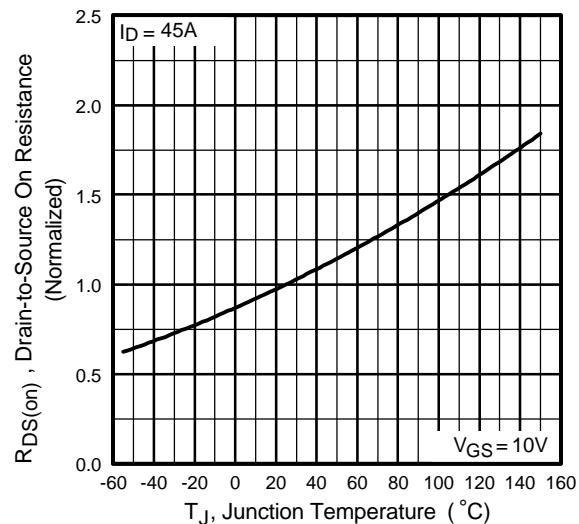


Fig 4. Normalized On-Resistance
Vs. Temperature

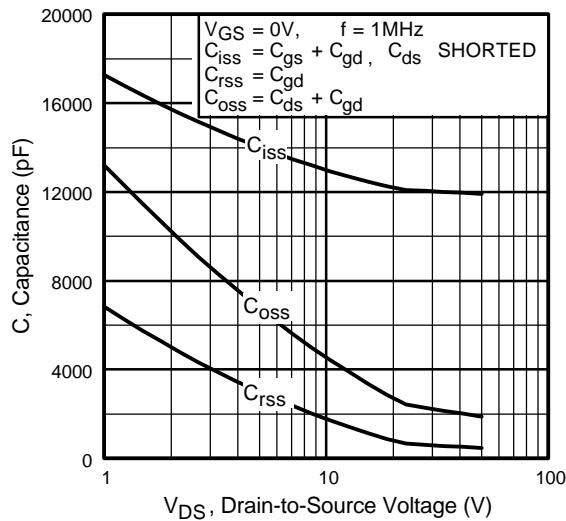


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

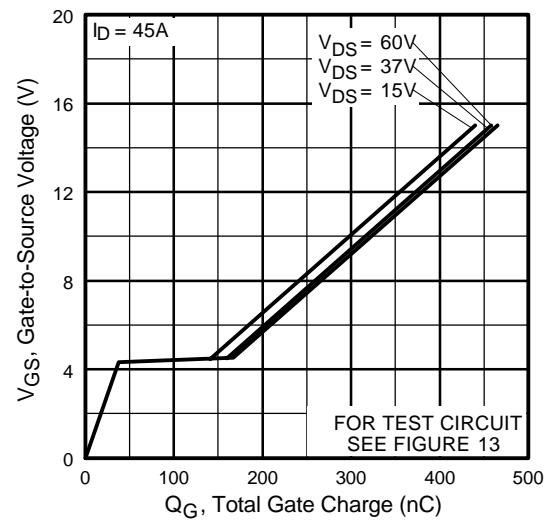


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

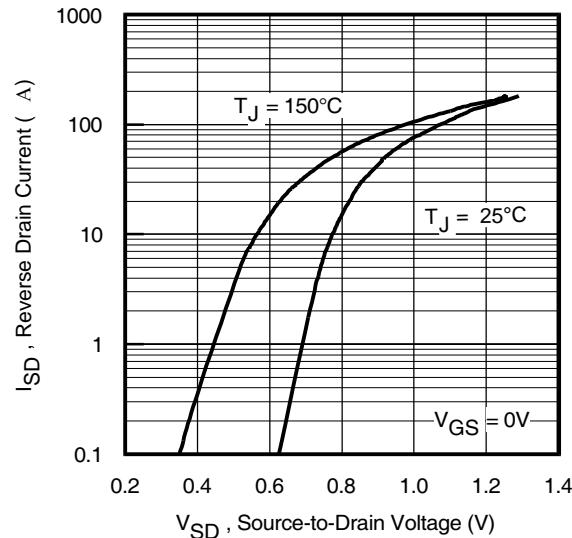


Fig 7. Typical Source-Drain Diode
Forward Voltage

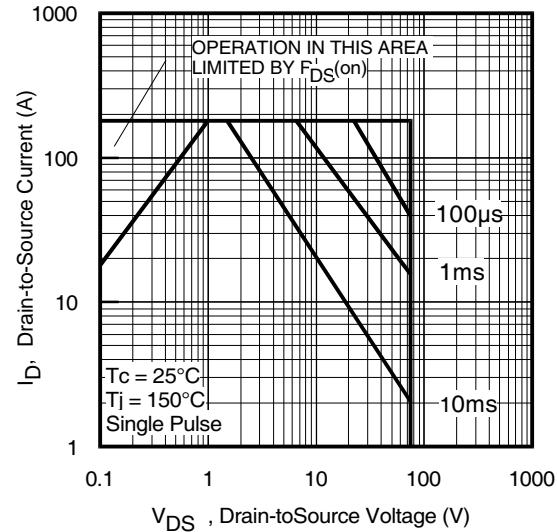


Fig 8. Maximum Safe Operating Area

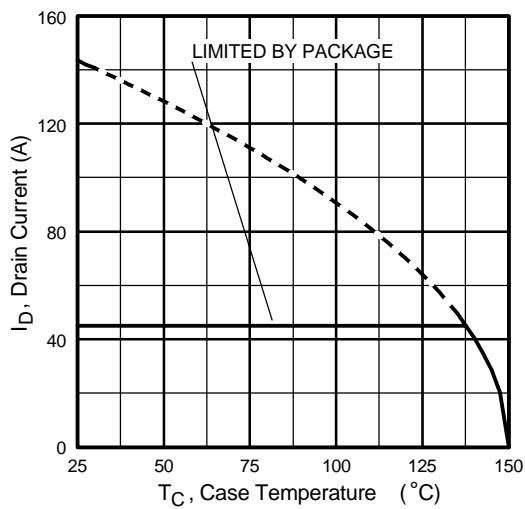


Fig 9. Maximum Drain Current Vs.
Case Temperature

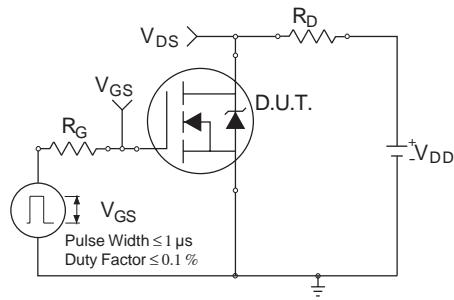


Fig 10a. Switching Time Test Circuit

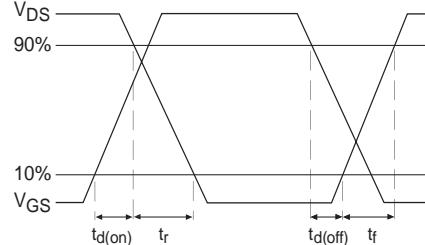


Fig 10b. Switching Time Waveforms

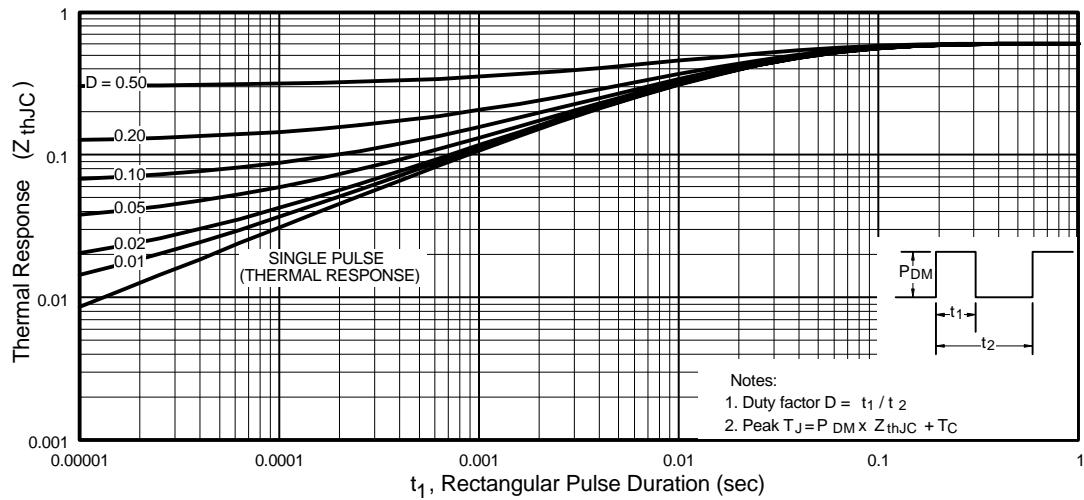
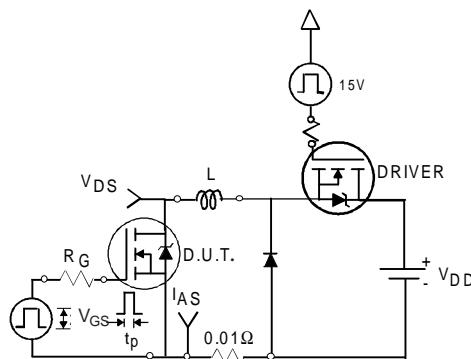
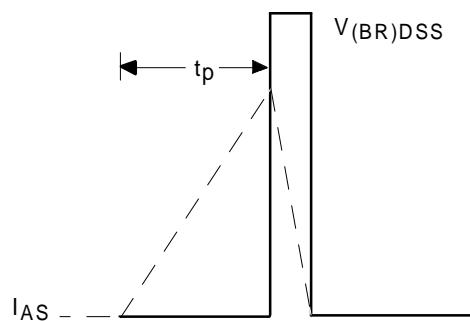
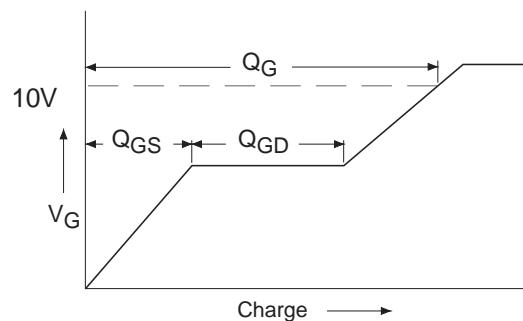
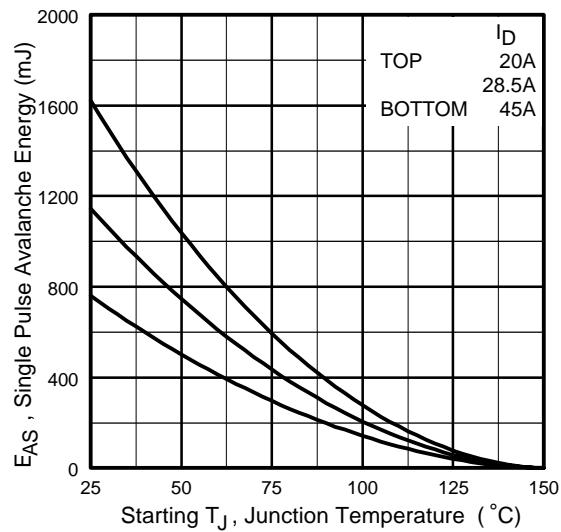
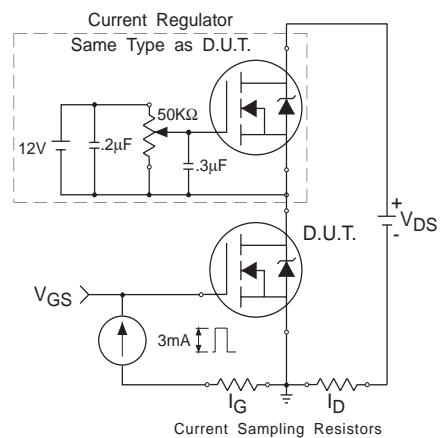


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

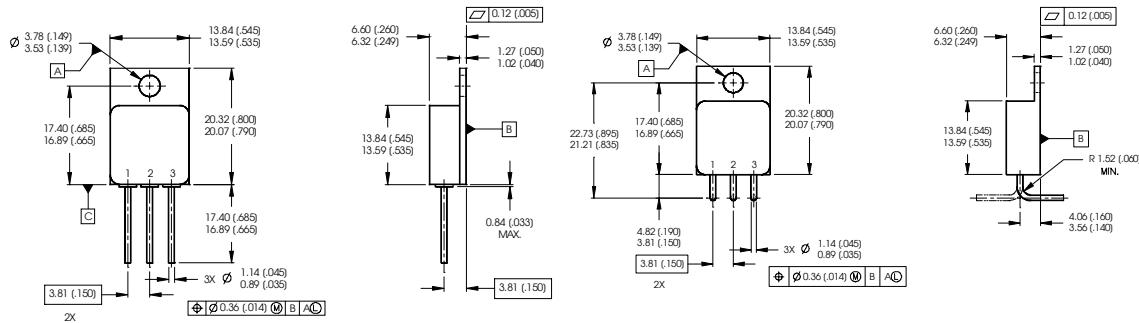
**Fig 12a.** Unclamped Inductive Test Circuit**Fig 12b.** Unclamped Inductive Waveforms**Fig 13a.** Basic Gate Charge Waveform**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current**Fig 13b.** Gate Charge Test Circuit

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② V_{DD} = 25 V, Starting T_J = 25°C, L = 0.75mH Peak I_{AS} = 45A, V_{GS} = 10V, R_G = 25Ω

- ③ I_{SD} ≤ 45A, dI/dt ≤ 380A/μs, V_{DD} ≤ 75V, T_J ≤ 150°C
- ④ Pulse width ≤ 300 μs; Duty Cycle ≤ 2%

Case Outline and Dimensions — Low-ohmic TO-254AA



NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
3. CONTROLLING DIMENSION: INCH.
4. CONFORMS TO JEDEC OUTLINE TO-254AA.

PIN ASSIGNMENTS

- 1 = DRAIN
- 2 = SOURCE
- 3 = GATE

CAUTION

BERYLLIA WARNING PER MIL-PRF-19500

Packages containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.

International
IR Rectifier

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